AUTOMOTIVE GRADE

AUIRFB8405

HEXFET[®] Power MOSFET

Features

- Advanced Process Technology
- New Ultra Low On-Resistance

International

ICR Rectifier

- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and wide variety of other applications.

Applications

- Electric Power Steering (EPS)
- Battery Switch
- Start/Stop Micro Hybrid
- Heavy Loads
- DC-DC Applications

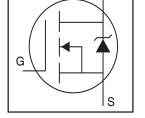
Base part number	Package Type	Standard Pack		Orderable Part Number
		Form	Quantity	
AUIRFB8405	TO-220	Tube	50	AUIRFB8405

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T_a) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	185 ①	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	131 ①	A
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	120	
I _{DM}	Pulsed Drain Current ②	904	
P _D @T _C = 25°C	Maximum Power Dissipation	163	W
	Linear Derating Factor	1.1	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw	10lbf· in (1.1N· m)	

HEXFET[®] is a registered trademark of International Rectifier. *Qualification standards can be found at http://www.irf.com/



D

V _{DSS}	40V
R _{DS(on)} typ.	2.1mΩ
max.	2.5m Ω
ID (Silicon Limited)	185A ①
ID (Package Limited)	120A



G	D	S
Gate	Drain	Source

Avalanche Characteristics

EAS (Thermally limited)	Single Pulse Avalanche Energy 3	181 247 See Fig. 14, 15, 24a, 24b		mJ	
E _{AS (tested)}	Single Pulse Avalanche Energy Tested Value ®			1110	
I _{AR}	Avalanche Current ©			A	
E _{AR}	Repetitive Avalanche Energy ②			mJ	
Thermal Resis	tance				
Symbol	Parameter	Тур.	Max.	Units	
R _{eJC}	Junction-to-Case ® ®		0.92		
R _{ecs}	Case-to-Sink, Flat, Greased Surface	0.50		°C/W	
R _{eJA}	Junction-to-Ambient		62	7	

Static @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	40			V	$V_{GS} = 0V, I_{D} = 250 \mu A$
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.026		V/°C	Reference to 25°C, $I_D = 1.0 \text{mA}^{\odot}$
R _{DS(on)}	Static Drain-to-Source On-Resistance		2.1	2.5	mΩ	V _{GS} = 10V, I _D = 100A ^⑤
V _{GS(th)}	Gate Threshold Voltage	2.2	3.0	3.9	V	$V_{DS} = V_{GS}, I_D = 100 \mu A$
I _{DSS}	Drain-to-Source Leakage Current			1.0		$V_{DS} = 40V, V_{GS} = 0V$
				150	μA	V _{DS} = 40V, V _{GS} = 0V, T _J = 125°C
GSS	Gate-to-Source Forward Leakage			100	n A	V _{GS} = 20V
	Gate-to-Source Reverse Leakage			-100		V _{GS} = -20V
R _G	Internal Gate Resistance		2.3		Ω	

Dynamic @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
gfs	Forward Transconductance	100			S	$V_{DS} = 10V, I_{D} = 100A$
Q _g	Total Gate Charge		107	161		I _D = 100A
Q _{gs}	Gate-to-Source Charge		29		nC	V _{DS} =20V
Q _{gd}	Gate-to-Drain ("Miller") Charge		39			V _{GS} = 10V ⑤
Q _{sync}	Total Gate Charge Sync. (Q _g - Q _{gd})		68			$I_{D} = 100A, V_{DS} = 0V, V_{GS} = 10V$
t _{d(on)}	Turn-On Delay Time		14			$V_{DD} = 26V$
t _r	Rise Time		128		ns	I _D = 100A
t _{d(off)}	Turn-Off Delay Time		55			$R_{G} = 2.7\Omega$
t _f	Fall Time		77			V _{GS} = 10V ^⑤
C _{iss}	Input Capacitance		5193			$V_{GS} = 0V$
C _{oss}	Output Capacitance		754			$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		519		pF	f = 1.0 MHz, See Fig. 5
C _{oss} eff. (ER)	Effective Output Capacitance (Energy Related)		878			$V_{GS} = 0V, V_{DS} = 0V$ to 32V \odot , See Fig. 11
C _{oss} eff. (TR)	Effective Output Capacitance (Time Related)		1225			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 32V $



Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current			185①		MOSFET symbol
	(Body Diode)			1050		showing the
I _{SM}	Pulsed Source Current			904		integral reverse 🔍 🗍
	(Body Diode) ②			304		p-n junction diode.
V _{SD}	Diode Forward Voltage		0.9	1.3	V	$T_J = 25^{\circ}C, I_S = 100A, V_{GS} = 0V$ (5)
dv/dt	Peak Diode Recovery ④		1.7		V/ns	$T_J = 175^{\circ}C, I_S = 100A, V_{DS} = 40V$
t _{rr}	Reverse Recovery Time		44		ns	$T_{\rm J} = 25^{\circ} C \qquad \qquad V_{\rm R} = 34 V,$
			45		115	$T_{\rm J} = 125^{\circ}C$ $I_{\rm F} = 100A$
Q _{rr}	Reverse Recovery Charge		44		nC	T _J = 25°C di/dt = 100A/µs ⑤
			46			$T_J = 125^{\circ}C$
I _{RRM}	Reverse Recovery Current		1.9		Α	$T_J = 25^{\circ}C$
t _{on}	Forward Turn-On Time	Intrins	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)			

Notes:

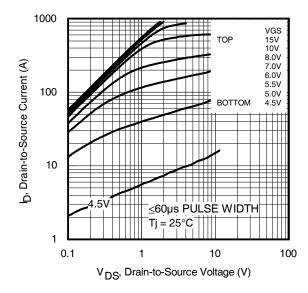
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- ① Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 120A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements. (Refer to AN-1140)
- $\ensuremath{\mathbb{O}}$ Repetitive rating; pulse width limited by max. junction temperature.
- (3) Limited by T_{Jmax} , starting $T_J = 25^{\circ}C$, L = 0.036mH, $R_G = 50\Omega$, $I_{AS} = 100A$, $V_{GS} = 10V$. Part not recommended for use above this value.
- $\label{eq:ISD} \textcircled{0.15mu}{0.15mu} {\rm (ISD} \leq 100A, \ di/dt \leq 1295A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^{\circ}C.$

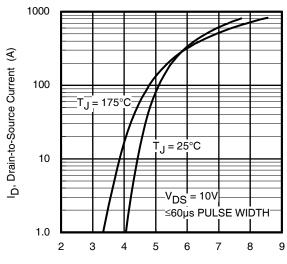
- \bigcirc Pulse width \leq 400µs; duty cycle \leq 2%.
- 6 C_{oss} eff. (TR) is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- \oslash C_{_{OSS}} eff. (ER) is a fixed capacitance that gives the same energy as C_{_{OSS}} while V_{_{DS}} is rising from 0 to 80% V_{_{DSS}}.
- \circledast $R_{\theta JC}$ value shown is at time zero.

I R



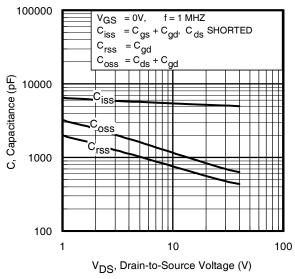


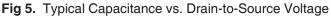




V_{GS}, Gate-to-Source Voltage (V)







4

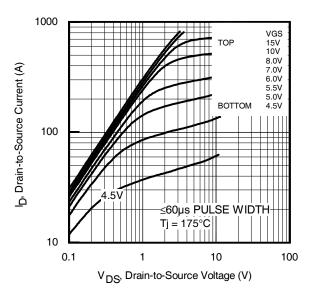
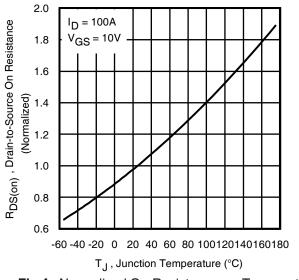


Fig 2. Typical Output Characteristics





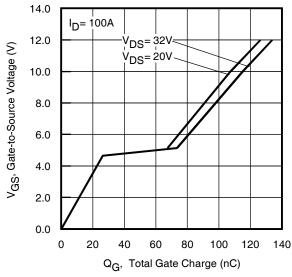
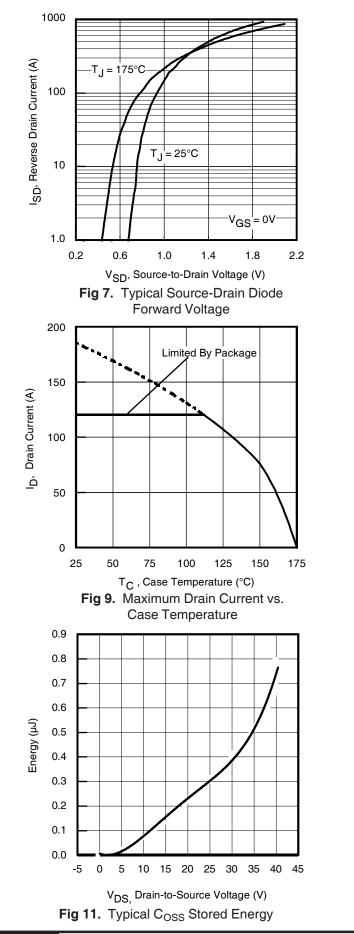
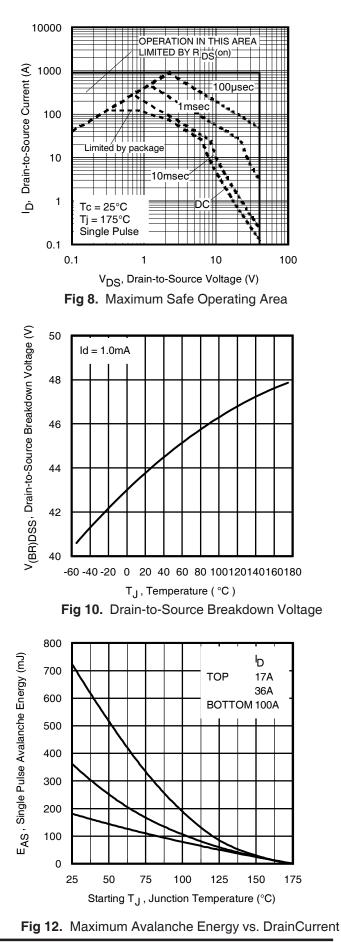


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

I R





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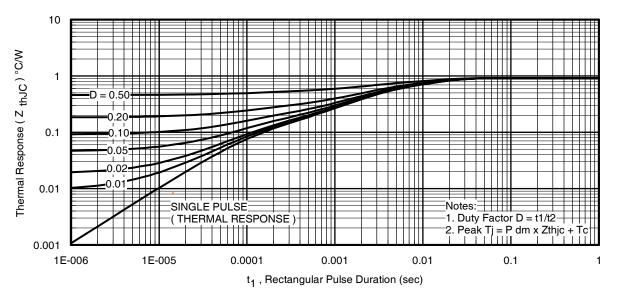


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

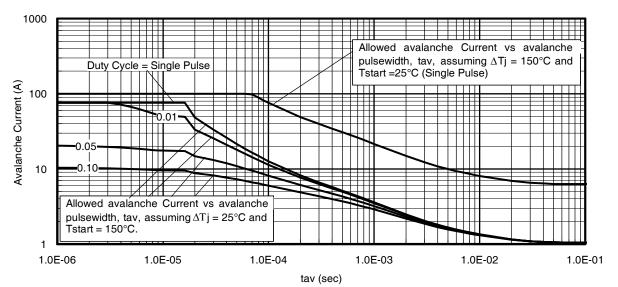
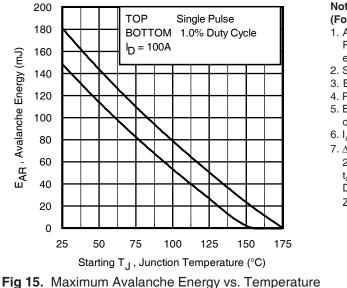


Fig 14. Typical Avalanche Current vs.Pulsewidth



Notes on Repetitive Avalanche Curves , Figures 14, 15 (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption:
- Purely a thermal phenomenon and failure occurs at a temperature far in excess of $T_{\rm jmax}.$ This is validated for every part type.
- Safe operation in Avalanche is allowed as long asT_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 24a, 24b.
- 4. $P_{D (ave)}$ = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7. Δ T = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 14, 15).
- t_{av =} Average time in avalanche.
- D = Duty cycle in avalanche = $t_{av} \cdot f$
- $Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D~(ave)} &= 1/2~(~1.3{\cdot}BV{\cdot}I_{av}) = \Delta T/~Z_{thJC} \\ I_{av} &= 2\Delta T/~[1.3{\cdot}BV{\cdot}Z_{th}] \\ E_{AS~(AR)} &= P_{D~(ave)}{\cdot}t_{av} \end{split}$$



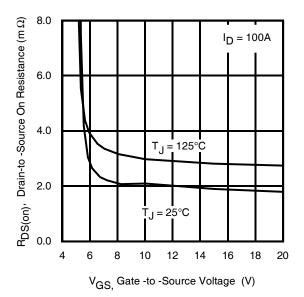


Fig 16. On-Resistance vs. Gate Voltage

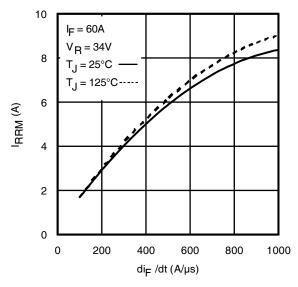
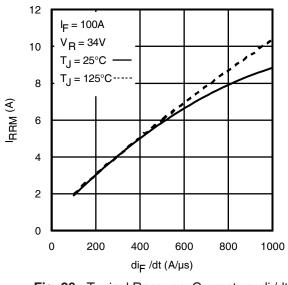
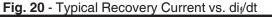


Fig. 18 - Typical Recovery Current vs. dif/dt





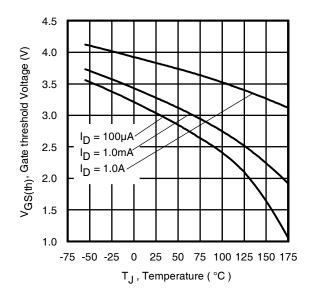


Fig 17. Threshold Voltage vs. Temperature

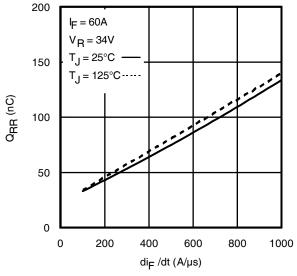
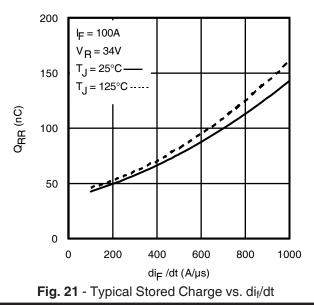


Fig. 19 - Typical Stored Charge vs. dif/dt



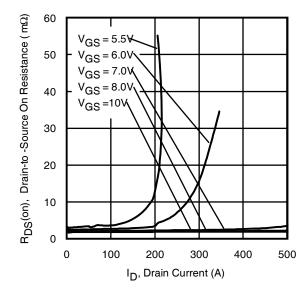
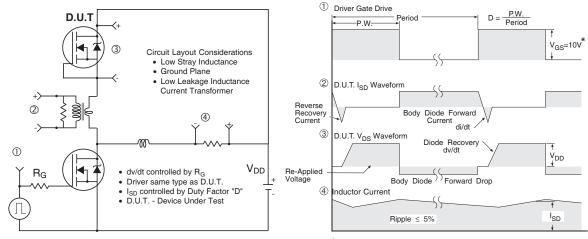


Fig 22. Typical On-Resistance vs. Drain Current

AUIRFB8405



* V_{GS} = 5V for Logic Level Devices

Fig 23. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET[®] Power MOSFETs

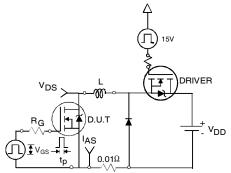


Fig 24a. Unclamped Inductive Test Circuit

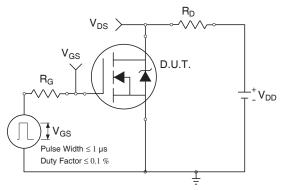


Fig 25a. Switching Time Test Circuit

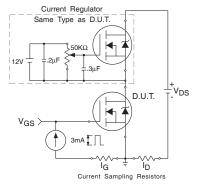


Fig 26a. Gate Charge Test Circuit

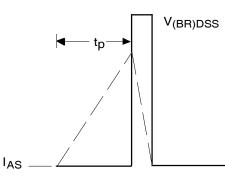
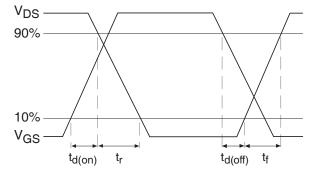
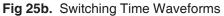


Fig 24b. Unclamped Inductive Waveforms





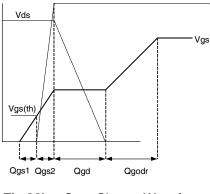


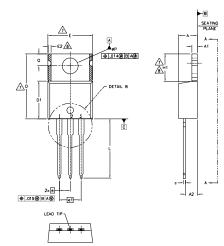
Fig 26b. Gate Charge Waveform

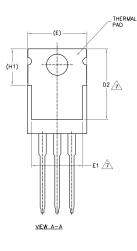
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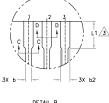


TO-220AB Package Outline

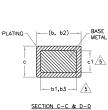
Dimensions are shown in millimeters (inches)







DETAIL B



NOTES:

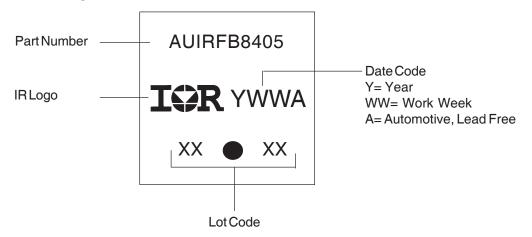
- S DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994. DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS]. LEAD DIMENSION AND FINISH UNCONTROLLED IN L1. DIMENSION D, D1 & E DO NOT INCLUDE MOLD FLASH. MENSION D, D1 & E DO NOT INCLUDE MOLD FLASH. SHALL NOT EXCEED .0057 (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY. 2.-3.-4.-
- <u>/5,</u>_ 6,-
- MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY, DIMENSION DIE 53 & CT APPLY TO BASE METAL ONLY. CONTROLLING DIMENSION : INCHES. THERMAL PAD CONTOR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1 DIMENSION ES X H1 DEFINE A ZOVE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED. 7 -
- 8.-
- 9.-
- OUTLINE CONFORMS TO JEDEC TO-220, EXCEPT A2 (max.) AND D2 (min.) WHERE DIMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE OUTLINE.

		DIMENSIONS						
SYMBOL	MILLIM	ETERS	INC	HES				
	MIN.	MAX.	MIN.	MAX.	NOTES			
A	3.56	4.83	.140	.190				
A1	0.51	1.40	.020	.055				
A2	2.03	2.92	.080	.115				
b	0.38	1.01	.015	.040				
b1	0.38	0.97	.015	.038	5			
b2	1.14	1.78	.045	.070				
b3	1.14	1,73	.045	.068	5			
с	0.36	0.61	.014	.024				
c1	0.36	0.56	.014	.022	5			
D	14.22	16.51	.560	.650	4			
D1	8.38	9.02	.330	.355				
D2	11.68	12.88	.460	.507	7			
E	9.65	10.67	.380	.420	4,7			
E1	6.86	8.89	.270	.350	7			
E2	-	0.76	-	.030	8			
e	2.54	BSC		BSC				
e1	5.08	BSC	.200	BSC				
H1	5.84	6.86	.230	.270	7,8			
L	12,70	14,73	.500	.580				
L1	3.56	4.06	.140	.160	3			
øP	3.54	4.08	.139	.161				
Q	2.54	3.42	.100	.135				

LEAD ASSIGNMENTS HEXFET

1,- Gate 2.- Drain 3.- Source IGBTS. CoPACK 1.- GATE 2.- Collector 3.- Emitter DIODES 1.- ANODE 2.- CATHODE 3.- ANODE

TO-220AB Part Marking Information



TO-220AB packages are not recommended for Surface Mount Application.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information[†]

				Αι	utomotive				
			(per AEC-Q101)						
Qualification Level		Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.							
		TO-220			N/A				
	Machine Model	Class M3 (+/- 400V) ^{††}							
		AEC-Q101-002							
	Human Body Model	Class H1C (+/- 2000V) ^{††}							
ESD				AEC	C-Q101-001				
	Charged Device Model			Class C	5 (+/- 2000V) ^{††}				
		AEC-Q101-005							
RoHS Compliant		Yes							

† Qualification standards can be found at International Rectifier's web site: http://www.irf.com/

†† Highest passing voltage.

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For technical support, please contact IR's Technical Assistance Center

http://www.irf.com/technical-info/

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Tel: (310) 252-7105

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